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FCP067N65S3

N-Channel SuperFET[®] III MOSFET 650 V, 44 A, 67 m Ω

Features

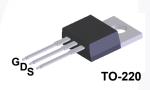
- 700 V @ T_J = 150 °C
- Typ. $R_{DS(on)}$ = 59 m Ω
- Ultra Low Gate Charge (Typ. Q_g = 78 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 715 pF)
- · 100% Avalanche Tested
- RoHS Compliant

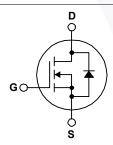
Applications

- Telecom / Sever Power Supplies
- · Industrial Power Supplies
- UPS / Solar

Description

SuperFET® III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate. Consequently, SuperFET III MOSFET is very suitable for various power system for miniaturization and higher efficiency.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FCP067N65S3	Unit
V_{DSS}	Drain to Source Voltage			650	V
\/	Cata ta Sauraa Valtaga	- DC		±30	V
V_{GSS}	Gate to Source Voltage	- AC	(f>1 Hz)	±30	_ v
I _D	Drain Current	- Continuous (T _C = 25°C)		44	
	Drain Current	- Continuous (T _C = 100°C)		28	A
I _{DM}	Drain Current	- Pulsed	(Note 1)	110	Α
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		214	mJ	
I _{AS}	Avalanche Current		(Note 1)	4.8	Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	3.12	mJ
du/dt	MOSFET dv/dt		100	1//	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		20	V/ns	
D	Davier Dissination	(T _C = 25°C)		312	W
P_{D}	Power Dissipation - Derate Above 25°C		2.5	W/°C	
T _J , T _{STG}	Operating and Storage Temperatu	Operating and Storage Temperature Range			οС
TL	Maximum Lead Temperature for S	oldering, 1/8" from Case for 5 Se	econds	300	οС

Thermal Characteristics

Symbol	Parameter	FCP067N65S3	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	30/00

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCP067N65S3	FCP067N65S3	TO-220	Tube	N/A	N/A	50 units

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Chara	cteristics					
D\/	Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}, T_J = 25^{\circ}\text{C}$	650	-	-	V
BV _{DSS}	Drain to Source Breakdown voltage	$V_{GS} = 0 \text{ V, I}_{D} = 1 \text{ mA, T}_{J} = 150^{\circ}\text{C}$	700	-	-	V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 1 mA, Referenced to 25°C	-	0.72	-	V/°C
1	Zero Gate Voltage Drain Current	V _{DS} = 650 V, V _{GS} = 0 V	-	-	1	
I _{DSS}	Zelo Gate Voltage Drain Current	$V_{DS} = 520 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-	2.2	-	μΑ
I _{GSS}	Gate to Body Leakage Current	V _{GS} = ±30 V, V _{DS} = 0 V	-	-	±100	nA

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 4.4 \text{ mA}$	2.5	-	4.5	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 22 A	-	59	67	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 20 V, I _D = 22 A	-	29	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V _{DS} = 400V, V _{GS} = 0 V,	-	3090	-	pF
C _{oss}	Output Capacitance	f = 1 MHz	-	68	-	pF
C _{oss(eff.)}	Effective Output Capacitance	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	715	-	pF
C _{oss(er.)}	Energy Related Output Capacitance	V _{DS} = 0 V to 400 V, V _{GS} = 0 V	-	104	-	pF
Q _{g(tot)}	Total Gate Charge at 10V	V _{DS} = 400 V, I _D = 22 A,	-	78	-	nC
Q_{gs}	Gate to Source Gate Charge	V _{GS} = 10 V	-	18	-	nC
Q_{gd}	Gate to Drain "Miller" Charge	(Note 4)	-	30	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	0.6	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		- /	26	-	ns
t _r		$V_{DD} = 400 \text{ V}, I_D = 22 \text{ A},$	- /	52	-	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_g = 4.7 \Omega$	-	89	-	ns
t _f	Turn-Off Fall Time	(Note 4)	-/-	16	-	ns

Source-Drain Diode Characteristics

I _S	Maximum Continuous Drain to Source Dioc	Maximum Continuous Drain to Source Diode Forward Current		-	44	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	110	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 22 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 22 A,	-	435	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	9.2	-	μС

Notes:

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. I $_{AS}$ = 4.8 A, VDD = 50 V, R $_{G}$ = 25 Ω , starting T $_{J}$ = 25°C.
- 3. $I_{SD} \le 22$ A, di/dt ≤ 200 A/ μ s, $V_{DD} \le 380$ V, starting T_J = 25° C.
- ${\bf 4.} \ Essentially \ independent \ of \ operating \ temperature \ typical \ characteristics.$

Typical Performance Characteristics

Figure 1. On-Region Characteristics

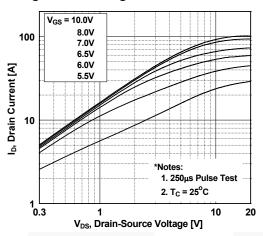


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

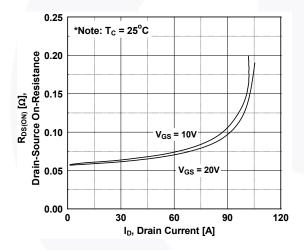


Figure 5. Capacitance Characteristics

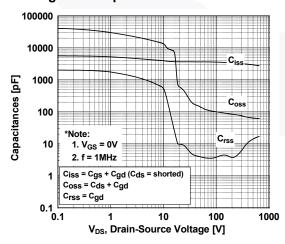


Figure 2. Transfer Characteristics

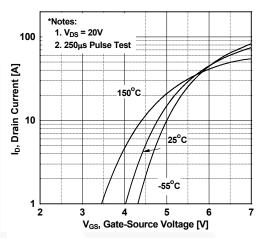


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

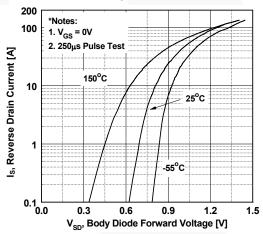
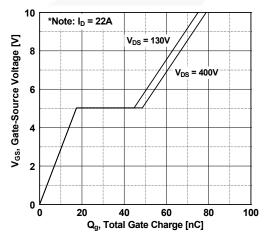


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

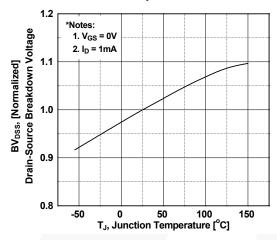


Figure 9. Maximum Safe Operating Area

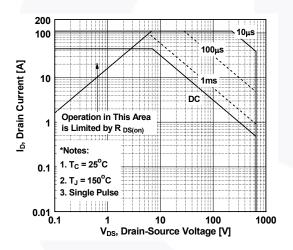


Figure 11. Eoss vs. Drain to Source Voltage

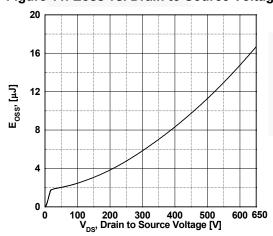


Figure 8. On-Resistance Variation vs. Temperature

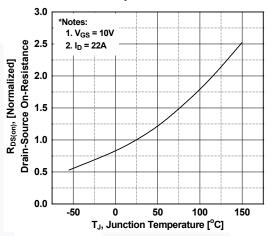
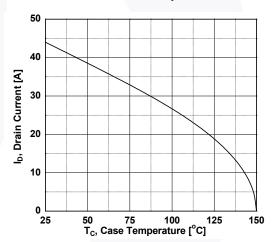
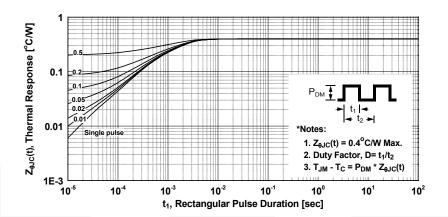


Figure 10. Maximum Drain Current vs. Case Temperature



Typical Performance Characteristics (Continued)

Figure 12. Transient Thermal Response Curve



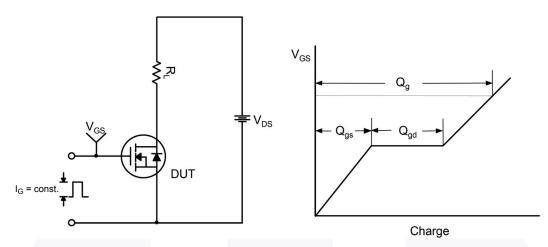


Figure 13. Gate Charge Test Circuit & Waveform

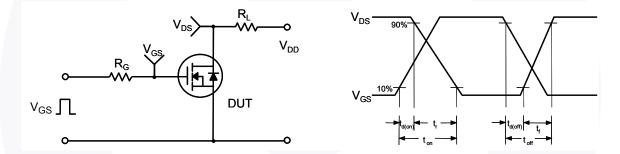


Figure 14. Resistive Switching Test Circuit & Waveforms

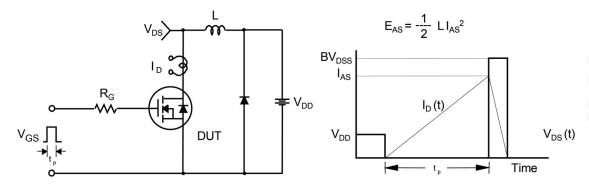


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

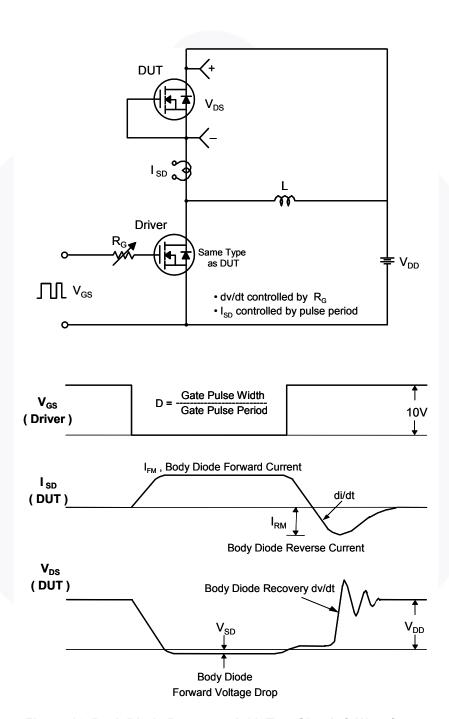


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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